## SN54ALS157A, SN54ALS158 SN74ALS157A, SN74ALS158, SN74AS157, SN74AS158 QUADRUPLE 1-OF-2 DATA SELECTORS/MULTIPLEXERS

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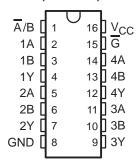
- Buffered Inputs and Outputs
- Package Options Include Plastic Small-Outline (D) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

#### description

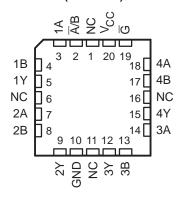
These data selectors/multiplexers contain inverters and drivers to supply full data selection to the four output gates. A separate strobe  $(\overline{G})$  input is provided. A 4-bit word is selected from one of two sources and is routed to the four outputs. The 'ALS157A and SN74AS157 present true data. The 'ALS158 and SN74AS158 present inverted data to minimize propagation delay time.

The SN54ALS157A and SN54ALS158 are characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ALS157A, SN74ALS158, SN74AS157, and SN74AS158 are characterized for operation from 0°C to 70°C.

SN54ALS157A, SN54ALS158...J PACKAGE SN74ALS157A, SN74ALS158, SN74AS157, SN74AS158...D OR N PACKAGE (TOP VIEW)



SN54ALS157A, SN54ALS158 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

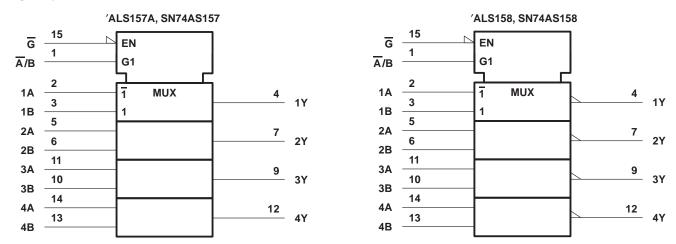
#### **FUNCTION TABLE**

INPUTS				OUTF	PUT Y
		DATA		'ALS157A	′ALS158
G	A/B	Α	В	SN74AS157	SN74AS158
Н	Χ	Х	Х	L	Н
L	L	L	Χ	L	Н
L	L	Н	Χ	Н	L
L	Н	Х	L	L	Н
L	Н	Х	Н	Н	L

# SN54ALS157A, SN54ALS158 SN74ALS157A, SN74ALS158, SN74AS157, SN74AS158 QUAD 1-OF-2 DATA SELECTORS/MULTIPLEXERS

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## logic symbols†

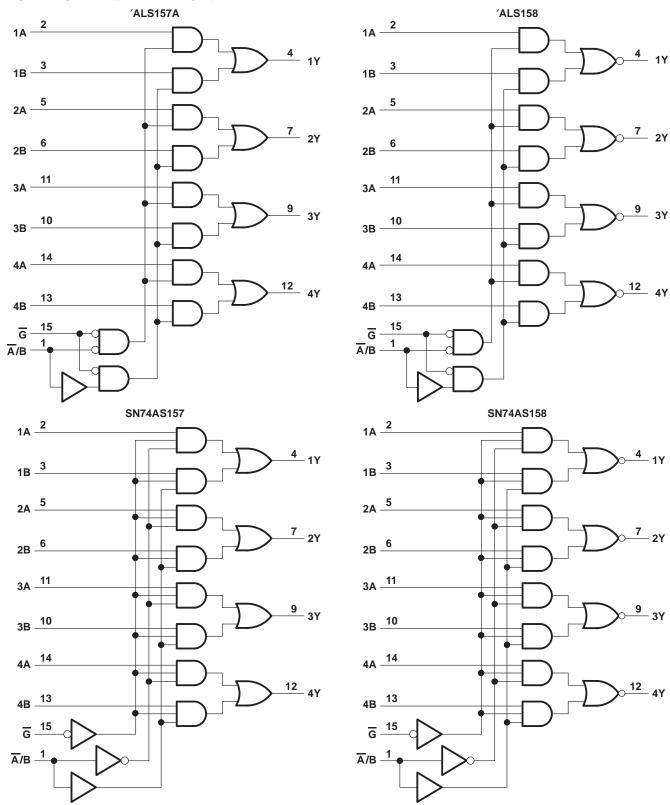


<sup>&</sup>lt;sup>†</sup> These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the D, J, and N packages.



## logic diagrams (positive logic)

Pin numbers shown are for the D, J, and N packages.





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## SN54ALS157A, SN54ALS158 SN74ALS157A, SN74ALS158, SN74AS157, SN74AS158 QUAD 1-OF-2 DATA SELECTORS/MULTIPLEXERS

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## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V <sub>CC</sub>	7 V
Input voltage, V <sub>I</sub>	7 V
Operating free-air temperature range, T <sub>A</sub> : SN54ALS157A, SN54ALS158	-55°C to 125°C
SN74ALS157A, SN74ALS158	0°C to 70°C
Storage temperature range	-65°C to 150°C

#### recommended operating conditions

			4ALS15 54ALS1		SN74ALS157A SN74ALS158		UNIT	
		MIN	NOM	MAX	MIN	NOM	MAX	
Vcc	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
VIL	Low-level input voltage			0.7			0.8	V
IOH	High-level output current			-0.4			-0.4	mA
IOL	Low-level output current			4			8	mA
TA	Operating free-air temperature	-55		125	0		70	°C

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		SN54ALS157A TEST CONDITIONS SN54ALS158			SN74ALS157A SN74ALS158			UNIT
				MIN	TYP‡	MAX	MIN	TYP‡	MAX	
VIK		V <sub>CC</sub> = 4.5 V,	$I_{I} = -18 \text{ mA}$			-1.2			-1.2	V
Vон		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -0.4 \text{ mA}$	V <sub>CC</sub> -	2		V <sub>CC</sub> -2	2		V
Mari		V <sub>CC</sub> = 4.5 V	$I_{OL} = 4 \text{ mA}$		0.25	0.4		0.25	0.4	V
VOL		VCC = 4.5 V	$I_{OL} = 8 \text{ mA}$					0.35	0.5	
Ц		$V_{CC} = 5.5 \text{ V},$	V <sub>I</sub> = 7 V			0.1			0.1	mA
lіН		$V_{CC} = 5.5 \text{ V},$	V <sub>I</sub> = 2.7 V			20			20	μΑ
I <sub>I</sub> L		$V_{CC} = 5.5 \text{ V},$	V <sub>I</sub> = 0.4 V			-0.1			-0.1	mA
ΙΟ§		V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 2.25 V	-20		-112	-30		-112	mA
laa	'ALS157A		See Note 1		6	11		6	11	mA
ICC	'ALS158	V <sub>CC</sub> = 5.5 V,	See Note 1		5	10		5	10	IIIA

<sup>‡</sup> All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .



<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

<sup>§</sup> The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS. NOTE 1: ICC is measured with 4.5 V applied to all inputs and all outputs open.

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## switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$V_{CC}$ = 5 V, $C_L$ = 50 pF, $R_L$ = 500 $\Omega$ , $T_A$ = 25°C	C <sub>L</sub> R <sub>L</sub>	= 50 pF = 500 £		,	UNIT
		` ′	'ALS157A	SN54AL	S157A	SN74ALS157A		
			TYP	MIN	MAX	MIN	MAX	
<sup>t</sup> PLH	A or B	Y	9	4	17	4	14	ns
<sup>t</sup> PHL	AOIB	Y	6	2	15	2	12	115
<sup>t</sup> PLH	Ā/B	V	15	7	28	7	24	ns
<sup>t</sup> PHL	A/B	Y	9	4	20	4	17	115
<sup>t</sup> PLH			14	7	25	7	20	ns
t <sub>PHL</sub>	9	Y	10	4	18	4	13	115

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

## switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$V_{CC} = 5 \text{ V},$ $C_L = 50 \text{ pF},$ $R_L = 500 \Omega,$ $T_A = 25^{\circ}\text{C}$	C <sub>L</sub> R <sub>L</sub>	= 50 pF = 500 C		,	UNIT
	, ,	, ,	′ALS158	SN54AL	.S158	SN74AL	.S158	
			TYP	MIN	MAX	MIN	MAX	
t <sub>PLH</sub>	A or B	V	9	4	18	4	15	ns
<sup>t</sup> PHL	AOIB	Y	5	2	12	2	8	115
<sup>t</sup> PLH		V	13	5	22	5	18	ns
<sup>t</sup> PHL	Ā/B	Y	13	5	22	5	18	115
<sup>t</sup> PLH	G	V	13	5	22	5	18	ns
<sup>t</sup> PHL	G	ľ	13	5	22	5	18	115

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

## SN54ALS157A, SN54ALS158 SN74ALS157A, SN74ALS158, SN74AS157, SN74AS158 QUAD 1-OF-2 DATA SELECTORS/MULTIPLEXERS

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## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V <sub>CC</sub>	7 V
Input voltage, V <sub>I</sub>	7 V
Operating free-air temperature range, T <sub>A</sub> : SN74AS157, SN74AS158	0°C to 70°C
Storage temperature range	-65°C to 150°C

#### recommended operating conditions

		SN74AS157 SN74AS158			UNIT
		MIN	NOM	MAX	
Vсс	Supply voltage	4.5	5	5.5	V
VIH	High-level input voltage	2			V
VIL	Low-level input voltage			0.8	V
IOH	High-level output current			-2	mA
loL	Low-level output current			20	mA
TA	Operating free-air temperature	0		70	°C

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST COND	TEST CONDITIONS			SN74AS157 SN74AS158			
						MAX			
٧ıĸ		V <sub>CC</sub> = 4.5 V,	I <sub>I</sub> = -18 mA			-1.2	V		
Vон		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -2 \text{ mA}$	V <sub>CC</sub> -2			V		
VOL		$V_{CC} = 4.5 \text{ V},$	$I_{OL} = 20 \text{ mA}$		0.35	0.5	V		
I.	Ā/B	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 7 V			0.2	A		
l <sub>l</sub>	A, B, or G					0.1	mA		
I.e.	Ā/B	V 55V	V: 0.7.V			40			
IН	A, B, or G	$V_{CC} = 5.5 V$	V <sub>I</sub> = 2.7 V			20	μΑ		
L	Ā/B	V 55V	V: 0.4.V			-1	A		
ll	A, B, or G	$V_{CC} = 5.5 V,$	$V_1 = 0.4 V$			-0.5	mA		
ΙΟ§		V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 2.25 V	-30		-112	mA		
	SN74AS157	V 55V			17.5	28	A		
ICC	SN74AS158	$V_{CC} = 5.5 V$			15.6	22.5	mA		

<sup>‡</sup> All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .



<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

<sup>§</sup> The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

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## switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$ $C_L = 50 \text{ pF},$ $R_L = 500 \Omega,$ $T_A = \text{MIN to MAX}^{\dagger}$ $\text{SN74AS157}$ $\text{MIN}  \text{MAX}$		UNIT
<sup>t</sup> PLH	A or B	V	1	6	
t <sub>PHL</sub>	AUID	Y	1	5.5	ns
<sup>t</sup> PLH		V	2	11	
t <sub>PHL</sub>	Ā/B	Y	2	10	ns
<sup>t</sup> PLH	G		2	10.5	200
<sup>t</sup> PHL	9	Y	2	7.5	ns

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

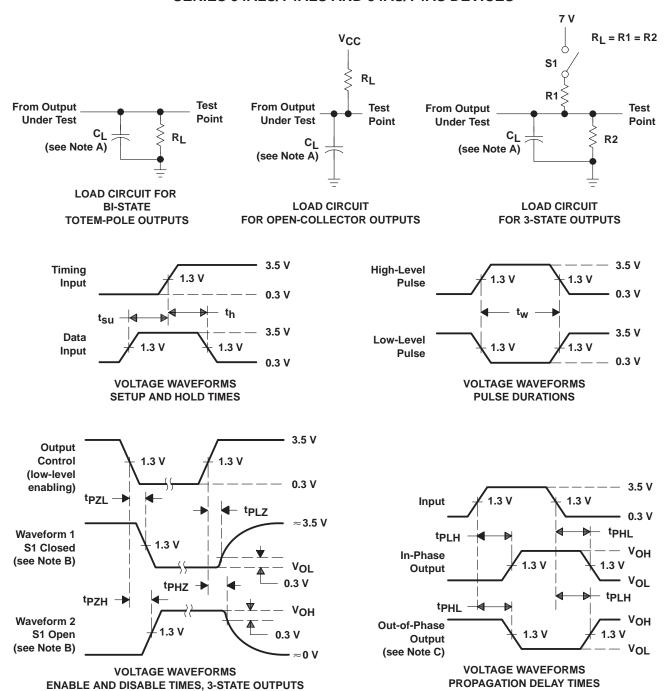
## switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$ $C_L = 50 \text{ pF},$ $R_L = 500 \Omega,$ $T_A = \text{MIN to MAX}^{\dagger}$ $\text{SN74AS158}$ $\text{MIN MAX}$		UNIT
t <sub>PLH</sub>	A or B		1	5	
<sup>t</sup> PHL	AUB	Υ	1	4.5	ns
<sup>t</sup> PLH	Ā/B	٧	2	9.5	
<sup>t</sup> PHL	A/B	Y	2	10.5	ns
<sup>t</sup> PLH	G	<b>~</b>	2	6.5	ns
<sup>†</sup> PHL	9	ſ	2	10	1115

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

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#### PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



- NOTES: A.  $C_L$  includes probe and jig capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
  - C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
  - D. All input pulses have the following characteristics:  $PRR \le 1$  MHz,  $t_f = t_f = 2$  ns, duty cycle = 50%.
  - E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms



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